Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/603,271	SHANAHAN	
Examiner	Art Unit	
BINH K. TIEU	2614	

SEARCHED				
Class	Subclass	Date	Examiner	
455	414.1	6/9/2007	ВКТ	
	415			
	502, 557			
	566-567			
<b>V</b>	418-419			
379	88.13			
348	14.06			
725	1, 21			
11	46, 104			
709	219	<b>V</b>		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST DATABASES SEARCH	6/9/2007	вкт		
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